HEFT<sup>®</sup> ISOMETRIC

# International **ICR** Rectifier

## AUTOMOTIVE GRADE

Automotive DirectFET<sup>®</sup> Power MOSFET 2

- Advanced Process Technology
- Optimized for Automotive Motor Drive, DC-DC and other Heavy Load Applications
- Exceptionally Small Footprint and Low Profile
- High Power Density
- Low Parasitic Parameters
- Dual Sided Cooling
- 175°C Operating Temperature
- Repetitive Avalanche Capability for Robustness and Reliability
- Lead Free, RoHS Compliant and Halogen Free
- Automotive Qualified \*

V <sub>(BR)DSS</sub>	60V
R <sub>DS(on)</sub> typ.	<b>5.5m</b> Ω
max.	<b>7.0m</b> Ω
D (Silicon Limited)	68A
Q <sub>g</sub>	35nC

AUIRF7648M2TR

AUIRF7648M2TR1

Applicable DirectFET® Outline and	Substrate Outline ①

Applicable	DirectFET	Outline and Su	Ibstrate Outline ①	1		M4			
SB	SC		M2	M4		L4	L6	L8	
-									

### Description

The AUIRF7648M2 combines the latest Automotive HEXFET® Power MOSFET Silicon technology with the advanced DirectFET® packaging to achieve low gate charge as well as the lowest on-state resistance in a package that has the footprint of a SO-8 and only 0.7 mm profile. The DirectFET® package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infrared or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET® package allows dual sided cooling to maximize thermal transfer in automotive power systems.

This HEXFET® Power MOSFET is designed for applications where efficiency and power density are of value. The advanced DirectFET® packaging platform coupled with the latest silicon technology allows the AUIRF7648M2 to offer substantial system level savings and performance improvement specifically in motor drive, high frequency DC-DC and other heavy load applications on ICE, HEV and EV platforms. This MOSFET utilizes the latest processing techniques to achieve low on-resistance and low Qg per silicon area . Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for high current automotive applications.

### Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied Exposure to absolutemaximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T<sub>A</sub>) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
V <sub>DS</sub>	Drain-to-Source Voltage	60	- v
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	v
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	68	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	48	
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)3	14	A
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	179	
I <sub>DM</sub>	Pulsed Drain Current (5)	272	
$P_{D} @ T_{C} = 25^{\circ}C$	Power Dissipation ④	63	w
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation 3	2.5	vv
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) 6	70	
E <sub>AS</sub> (tested)	Single Pulse Avalanche Energy Tested Value 6	291	— mJ
I <sub>AR</sub>	Avalanche Current 5	See Fig. 18a,18b,16,17	А
E <sub>AR</sub>	Repetitive Avalanche Energy (5)		mJ
Т <sub>Р</sub>	Peak Soldering Temperature	270	
TJ	Operating Junction and	-55 to + 175	°C
T <sub>STG</sub>	Storage Temperature Range		

#### **Thermal Resistance**

	Parameter	Тур.	Max.	Units
$R_{ ext{ heta}JA}$	Junction-to-Ambient <sup>③</sup>		60	
$R_{ ext{ heta}JA}$	Junction-to-Ambient ®	12.5		
$R_{ ext{ heta}JA}$	Junction-to-Ambient ®	20		°C/W
$R_{\theta J-Can}$	Junction-to-Can ④ <sup>®</sup>		2.4	
$R_{\theta J-PCB}$	Junction-to-PCB Mounted	1.0		
	Linear Derating Factor ④	(	0.42	W/°C

HEXFET® is a registered trademark of International Rectifier.

### Static Characteristics @ $T_J = 25^{\circ}C$ (unless otherwise stated)

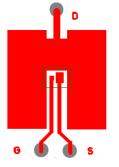
	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	60	_		V	$V_{GS} = 0V, I_{D} = 250 \mu A$
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.07		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		5.5	7.0	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 41A ⑦
V <sub>GS(th)</sub>	Gate Threshold Voltage	3.0	4.0	4.9	V	$V_{DS} = V_{GS}$ , $I_D = 150 \mu A$
$\Delta V_{GS(th)} / \Delta T_J$	Gate Threshold Voltage Coefficient		-12		mV/°C	$v_{DS} = v_{GS}, I_D = 150\mu A$
gfs	Forward Transconductance	44			S	$V_{DS} = 25V, I_{D} = 41A$
R <sub>G</sub>	Gate Resistance		1.4		Ω	
I <sub>DSS</sub>	Drain-to-Source Leakage Current			5	μA	$V_{DS} = 60V, V_{GS} = 0V$
				250		$V_{DS} = 60V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	<b>~</b> ^	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> = -20V

## Dynamic Characteristics @ $T_J = 25^{\circ}C$ (unless otherwise stated)

	Parameter	Min.	Тур.	Max.	Units	Conditions
Q <sub>g</sub>	Total Gate Charge		35	53		$V_{DS} = 30V, V_{GS} = 10V$
Q <sub>gs1</sub>	Pre-Vth Gate-to-Source Charge		7.7		1	I <sub>D</sub> = 41A
Q <sub>gs2</sub>	Post-Vth Gate-to-Source Charge		3.4		nC	See Fig.11
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge		14			
Q <sub>godr</sub>	Gate Charge Overdrive		9.9			
Q <sub>sw</sub>	Switch Charge (Q <sub>gs2</sub> + Q <sub>gd</sub> )		17.4		1	
Q <sub>oss</sub>	Output Charge		23		nC	$V_{DS} = 16V, V_{GS} = 0V$
t <sub>d(on)</sub>	Turn-On Delay Time		12			$V_{DD} = 30V, V_{GS} = 10V$ ⑦
t <sub>r</sub>	Rise Time		23			I <sub>D</sub> = 41A
t <sub>d(off)</sub>	Turn-Off Delay Time		19		ns	$R_{G} = 6.8\Omega$
t <sub>f</sub>	Fall Time		14		1	
C <sub>iss</sub>	Input Capacitance		2170			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		633			$V_{DS} = 25V$
C <sub>rss</sub>	Reverse Transfer Capacitance		162		pF	f = 1.0MHz
C <sub>oss</sub>	Output Capacitance		2661		1	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 1.0V, f=1.0MHz
C <sub>oss</sub>	Output Capacitance		465		1	$V_{GS} = 0V, V_{DS} = 48V, f=1.0MHz$
C <sub>oss</sub> eff.	Effective Output Capacitance		726		1	$V_{GS} = 0V, V_{DS} = 0V$ to 48V

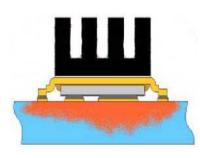
### Diode Characteristics @ $T_J = 25^{\circ}C$ (unless otherwise stated)

	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current			68		MOSFET symbol
	(Body Diode)			00	А	showing the
I <sub>SM</sub>	Pulsed Source Current			272		integral reverse
	(Body Diode) <sup>⑤</sup>			212		p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage			1.3	V	$I_S = 41A, V_{GS} = 0V$ ⑦
t <sub>rr</sub>	Reverse Recovery Time		36	54	ns	$I_F = 41A, V_{DD} = 25V$
Q <sub>rr</sub>	Reverse Recovery Charge		46	69	nC	di/dt = 100A/µs ⊘

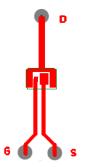


③ Surface mounted on 1 in. square Cu (still air).

Notes ① through <sup>①</sup> are on page 10



 Mounted to a PCB with small clip heatsink (still air)



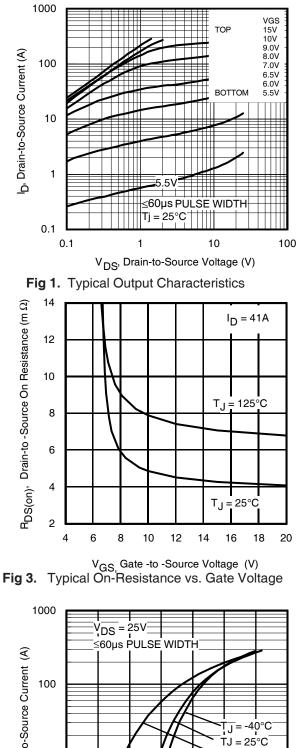
 Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air)

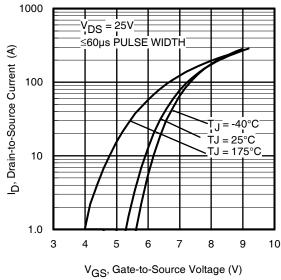
## Qualification Information<sup>†</sup>

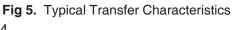
		Automotive (per AEC-Q101) <sup>††</sup>				
Qualification Lev		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moisture Sensitiv	/ity Level	MEDIUM-CAN MSL1, 260°C				
		Class M4 ( +/- 400V)				
	Machine Model	AEC-Q101-002				
505		Class H2( +/- 4000V)				
ESD	Human Body Model	AEC-Q101-001				
	Charged Device		N/A			
	Model	AEC-Q101-005				
RoHS Compliant		Yes				

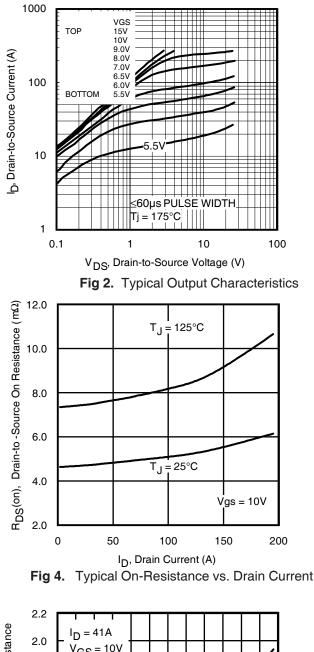
† Qualification standards can be found at International Rectifier's web site: <u>http://www.irf.com</u>

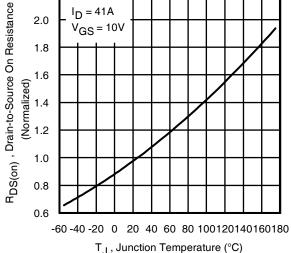
**††** Exceptions to AEC-Q101 requirements are noted in the qualification report.





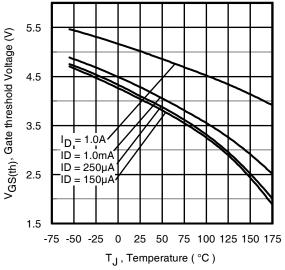


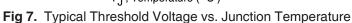






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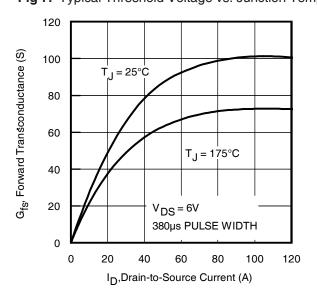


Fig 9. Typical Forward Transconductance Vs. Drain Current

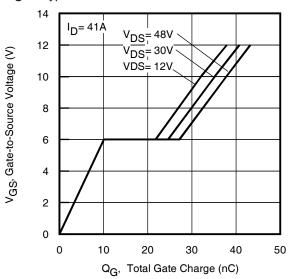


Fig.11 Typical Gate Charge vs.Gate-to-Source Voltage www.irf.com



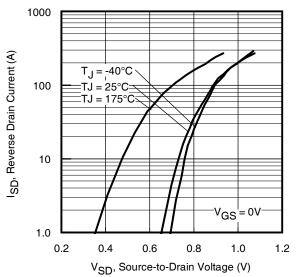


Fig 8. Typical Source-Drain Diode Forward Voltage

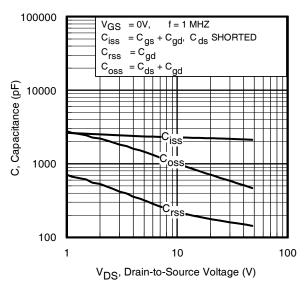


Fig 10. Typical Capacitance vs.Drain-to-Source Voltage

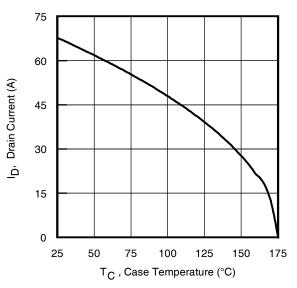


Fig 12. Maximum Drain Current vs. Case Temperature



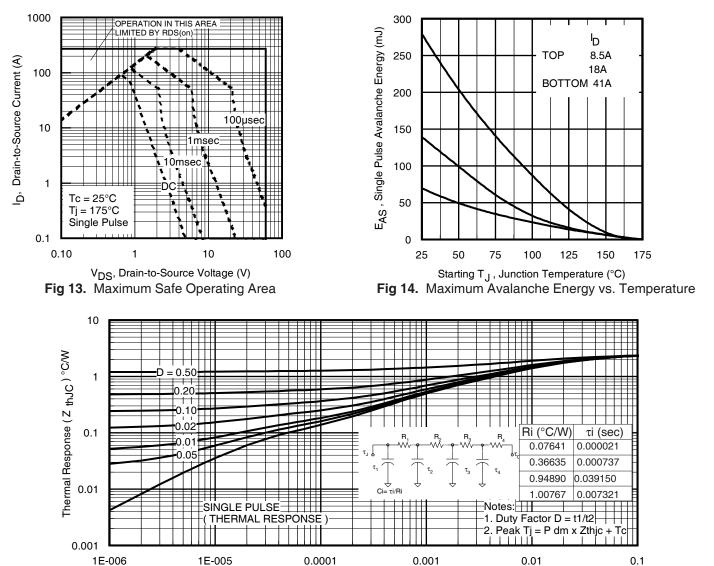


Fig 15. Maximum Effective Transient Thermal Impedance, Junction-to-Case

t1 , Rectangular Pulse Duration (sec)

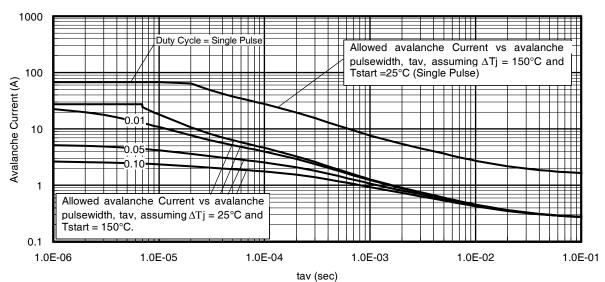
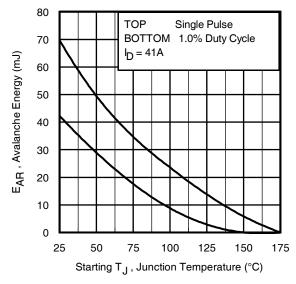
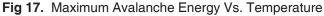


Fig 16. Typical Avalanche Current Vs.Pulsewidth

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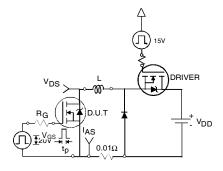


Fig 18a. Unclamped Inductive Test Circuit

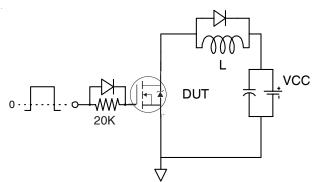


Fig 19a. Gate Charge Test Circuit

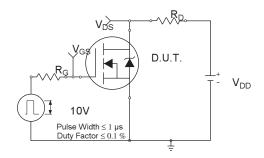


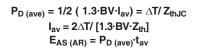
Fig 20a. Switching Time Test Circuit

# AUIRF7648M2TR/TR1

Notes on Repetitive Avalanche Curves , Figures 16, 17: (For further info, see AN-1005 at www.irf.com)

- Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>jmax</sub>. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long  $asT_{jmax}$  is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. P<sub>D (ave)</sub> = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 16, 17).
  - $t_{av}$  = Average time in avalanche. D = Duty cycle in avalanche =  $t_{av}$  f

 $Z_{\text{th,IC}}(D, t_{av}) = \text{Transient thermal resistance, see figure 15}$ 



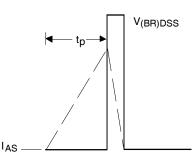


Fig 18b. Unclamped Inductive Waveforms

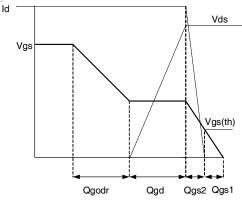


Fig 19b. Gate Charge Waveform

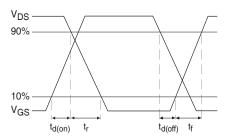
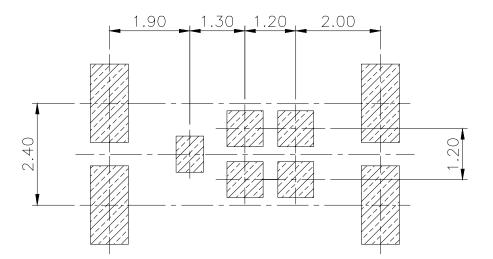
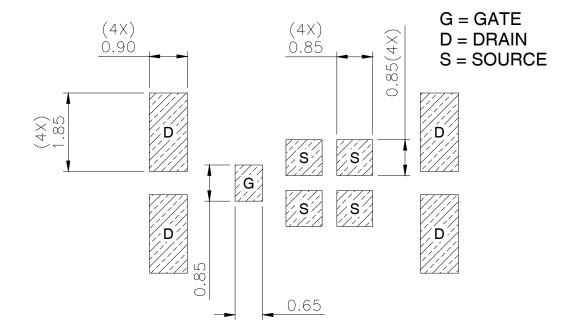


Fig 20b. Switching Time Waveforms

## DirectFET<sup>®</sup> Board Footprint, M4 (Medium Size Can).

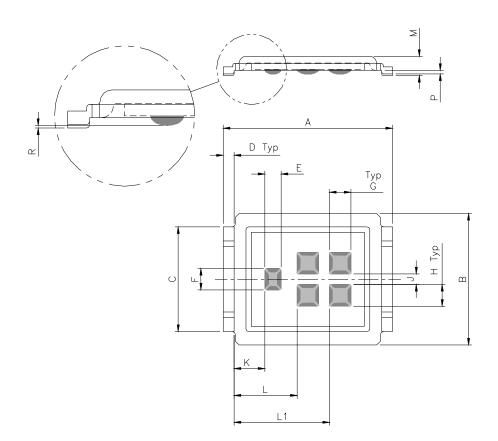
Please see AN-1035 for DirectFET® assembly details and stencil and substrate design recommendations





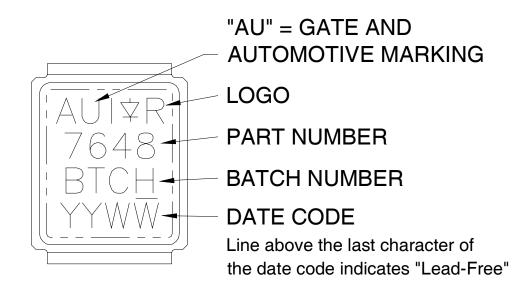
### DirectFET<sup>®</sup> Outline Dimension, M4 Outline (Medium Size Can).

Please see AN-1035 for DirectFET® assembly details and stencil and substrate design recommendations



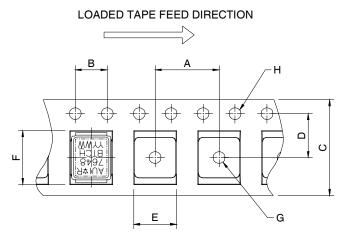
DIMENSIONS						
	MET	RIC	IMPERIAL			
CODE	MIN	MAX	MIN	MAX		
Α	6.25	6.35	0.246	0.250		
В	4.80	5.05	0.189	0.201		
С	3.85	3.95	0.152	0.156		
D	0.35	0.45	0.014	0.018		
Е	0.58	0.62	0.023	0.024		
F	0.78	0.82	0.031	0.032		
G	0.78	0.82	0.031	0.032		
Н	0.78	0.82	0.031	0.032		
J	0.38	0.42	0.015	0.017		
К	1.10	1.20	0.043	0.047		
L	2.30	2.40	0.090	0.094		
L1	3.50	3.60	0.138	0.142		
М	0.68	0.74	0.027	0.029		
Р	0.09	0.17	0.003	0.007		
R	0.02	0.08	0.001	0.003		

DirectFET<sup>®</sup> Part Marking



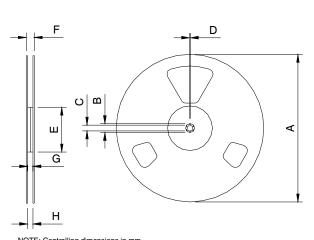
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

## DirectFET<sup>®</sup> Tape & Reel Dimension (Showing component orientation).



NOTE: CONTROLLING
DIMENSIONS IN MM

DIMENSIONS							
	MET	RIC	IMPE	RIAL			
CODE	MIN	MAX	MIN	MAX			
А	7.90	8.10	0.311	0.319			
В	3.90	4.10	0.154	0.161			
С	11.90	12.30	0.469	0.484			
D	5.45	5.55	0.215	0.219			
E	5.10	5.30	0.201	0.209			
F	6.50	6.70	0.256	0.264			
G	1.50	N.C	0.059	N.C			
Н	1.50	1.60	0.059	0.063			



NOTE: Controlling dimensions in mm Std reel quantity is 4800 parts. (ordered as AUIRF7648M2TR). For 1000 parts on 7" reel, order AUIRF7648M2TR1

REEL DIMENSIONS								
STANDARD OPTION (QTY 4800)					TR1 OPTION (QTY 1000)			
	METRIC		IMPERIAL		METRIC		IMPERIAL	
CODE	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX
Α	330.0	N.C	12.992	N.C	177.77	N.C	6.9	N.C
В	20.2	N.C	0.795	N.C	19.06	N.C	0.75	N.C
С	12.8	13.2	0.504	0.520	13.5	12.8	0.53	0.50
D	1.5	N.C	0.059	N.C	1.5	N.C	0.059	N.C
E	100.0	N.C	3.937	N.C	58.72	N.C	2.31	N.C
F	N.C	18.4	N.C	0.724	N.C	13.50	N.C	0.53
G	12.4	14.4	0.488	0.567	11.9	12.01	0.47	N.C
Н	11.9	15.4	0.469	0.606	11.9	12.01	0.47	N.C

#### Notes:

- ① Click on this section to link to the appropriate technical paper.
- O Click on this section to link to the <code>DirectFET</code> Website.
- ③ Surface mounted on 1 in. square Cu board, steady state.
- $\circledast\ T_C$  measured with thermocouple mounted to top (Drain) of part.
- S Repetitive rating; pulse width limited by max. junction temperature.
- 6 Starting  $T_J$  = 25°C, L = 0.084mH,  $R_G$  = 50 $\Omega,~I_{AS}$  = 41A,Vgs = 20V.
- O Pulse width  $\leq$  400µs; duty cycle  $\leq$  2%.
- $\circledast$  Used double sided cooling, mounting pad with large heatsink.
- In Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- @  $R_{\theta}$  is measured at  $T_{J}$  of approximately 90°C.

### **IMPORTANT NOTICE**

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For technical support, please contact IR's Technical Assistance Center <u>http://www.irf.com/technical-info/</u>

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